

Experiment No. 9

Common Emitter Configuration Experiment

1. OBJECTIVES

- ❖ To study the input and output characteristics of a transistor (Common Emitter configuration).

2. COMPONENTS REQUIRED

- ❖ DC Regulated Power supply(0-15V)
- ❖ Connecting wires.
- ❖ Digital Ammeters (0 - 200 mA, 0-200A).
- ❖ Tow Digital Voltmeter (0 - 20V).
- ❖ Resistors 1kΩ, 100 kΩ.
- ❖ Bread Board.
- ❖ (BC 141 npn) transistor.

**Specifications for Transistor -----: Max Collector Current = -----A; V_{CEO} max -----.

3. THEORY

Circuit Diagram

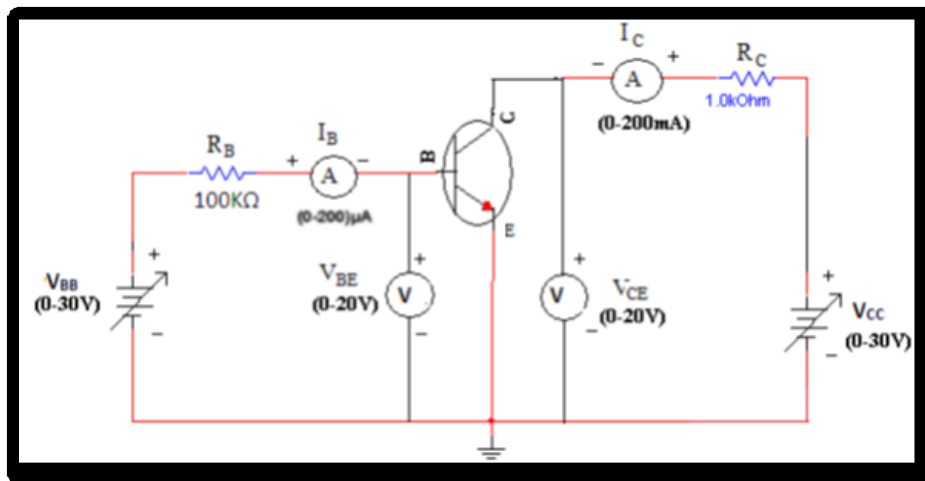


Fig. 1: Common Emitter configuration.

$$V_{BE} = V_{BB} - I_B R_B$$

$$V_{CE} = V_{CC} - I_C R_C$$

Operation:

Input characteristics are obtained between the input current I_B and input voltage V_{BE} at constant output voltage V_{CE} . This portion of an NPN BJT is just like a p-n junction. Consequently, the I_B and V_{BE} relationship in the common emitter configuration is the same as the I-V characteristic of a diode. The typical value of V_{BE} for silicon BJT is 0.7 V. After cut in voltage the I_B increases rapidly with small increase in V_{BE} . It means that dynamic input resistance is small in CE configuration. It is the ratio of change in V_{BE} to the resulting change in base current at constant collector emitter voltage. It is given by $\Delta V_{BE} / \Delta I_B$.

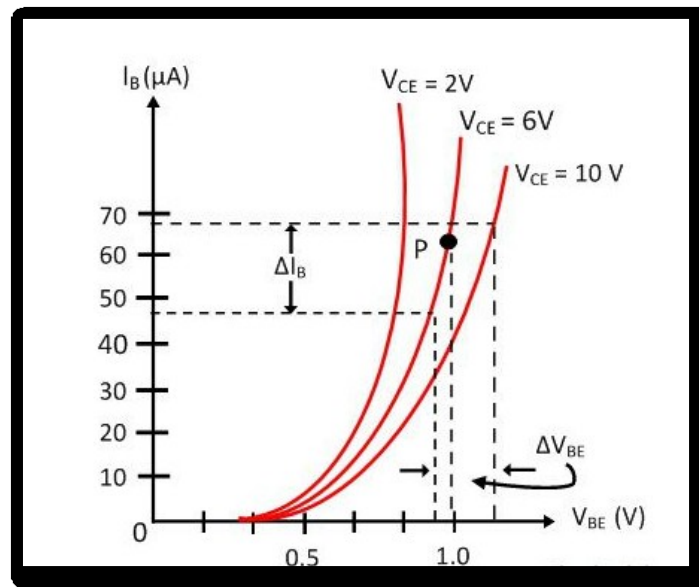


Fig. 2: Model for input I-V characteristic.

Output characteristics shows relation between collector current I_C and collector voltage for various values of base current. The change in collector emitter voltage causes small change in the collector current for the constant base current, which defines the dynamic resistance and is given as $\Delta V_{CE} / \Delta I_C$ at constant I_B . The output characteristic of common emitter configuration consists of three regions: Active, Saturation and Cut-off.

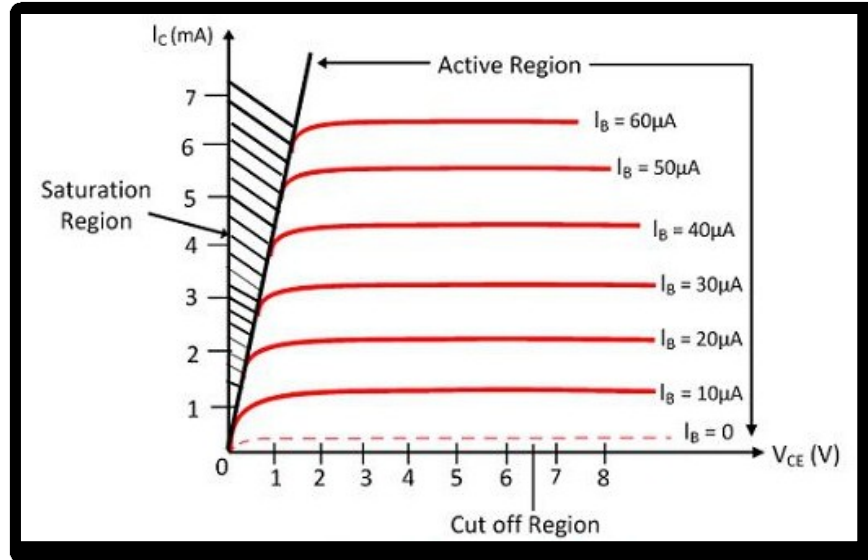


Fig. 3: Model for output I-V characteristic.

Active region: In this region base-emitter junction is forward biased and base-collector junction is reversed biased. The curves are approximately horizontal in this region.

Saturation region: In this region both the junctions are forward biased.

Cut-off: In this region, both the junctions are reverse biased. When the base current is made equal to zero, the collector current is reverse leakage current I_{CEO} . The region below $I_B = 0$ is the called the cutoff region.

4. PROCEDURE

Input Characteristics:

1. Connect the circuit as shown in the circuit diagram (Fig.1).
2. Keep output voltage $V_{CE} = 0V$ by varying V_{CC} .
3. Varying V_{BB} gradually, note down base current I_B and base-emitter voltage V_{BE} .
4. Step size is not fixed because of nonlinear curve. Initially vary V_{BB} in steps of $0.1V$. Once the current starts increasing vary V_{BB} in steps of $1V$.
5. Repeat above procedure (step 3) for $V_{CE} = 2V$ and $5V$.
6. Plot the input characteristics: V_{BE} on X-axis and I_B on Y-axis at a constant V_{CE} as a constant parameter.

Calculations:

1. Small-Signal Current Gain: $\beta = \Delta I_C / \Delta I_B$ with the V_{CE} at a constant voltage.
2. Dynamic input resistance: It is given by $\Delta V_{BE} / \Delta I_B$ at constant V_{CE} .
3. Dynamic output resistance: It is given as $\Delta V_{CE} / \Delta I_C$ at constant I_B .

Results:

1. Small-Signal Current Gain: _____
2. Dynamic input resistance: _____
3. Dynamic output resistance: _____